

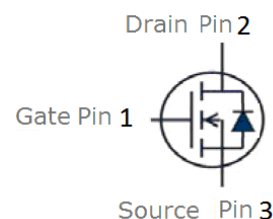
Features

- Enhancement mode
- Low on-resistance $R_{DS(on)}$ @ $V_{GS}=4.5\text{ V}$
- VitoMOS[®] II Technology
- 100% Avalanche test
- Pb-free lead plating; RoHS compliant



Part ID	Package Type	Marking	Tape and reel information
VS6610GI	TO-251	6610GI	75pcs/Tube

V_{DS}	60	V
$R_{DS(on),TYP}@ V_{GS}=10\text{ V}$	7.5	m Ω
$R_{DS(on),TYP}@ V_{GS}=4.5\text{ V}$	12.5	m Ω
I_D	60	A

TO-251


Maximum ratings, at $T_A=25^\circ\text{C}$, unless otherwise specified

Symbol	Parameter	Rating	Unit	
$V_{(BR)DSS}$	Drain-Source breakdown voltage	60	V	
V_{GS}	Gate-Source voltage	± 20	V	
I_S	Diode continuous forward current	$T_C=25^\circ\text{C}$	60	A
I_D	Continuous drain current @ $V_{GS}=10\text{V}$	$T_C=25^\circ\text{C}$	60	A
		$T_C=100^\circ\text{C}$	42	A
I_{DM}	Pulse drain current tested ①	$T_C=25^\circ\text{C}$	240	A
I_{DSM}	Continuous drain current @ $V_{GS}=10\text{V}$	$T_A=25^\circ\text{C}$	9	A
		$T_A=70^\circ\text{C}$	7	A
EAS	Avalanche energy, single pulsed ②	25	mJ	
P_D	Maximum power dissipation	$T_C=25^\circ\text{C}$	52	W
		$T_C=100^\circ\text{C}$	26	W
P_{DSM}	Maximum power dissipation ③	$T_A=25^\circ\text{C}$	1.25	W
		$T_A=70^\circ\text{C}$	0.8	W
T_{STG}, T_J	Storage and Junction Temperature Range	-55 to 175	$^\circ\text{C}$	

Thermal Characteristics

Symbol	Parameter	Typical	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	2.9	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	$^\circ\text{C/W}$

Electrical Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ T_j=25°C (unless otherwise stated)						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	60	--	--	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V	--	--	1	μA
	Zero Gate Voltage Drain Current(T _j =125°C)	V _{DS} =60V, V _{GS} =0V	--	--	100	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} =±20V, V _{DS} =0V	--	--	±100	nA
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	1.5	1.8	2.4	V
R _{DS(ON)}	Drain-Source On-State Resistance ④	V _{GS} =10V, I _D =20A	--	7.5	10	mΩ
		T _j =100°C	--	10	--	mΩ
R _{DS(ON)}	Drain-Source On-State Resistance ④	V _{GS} =4.5V, I _D =20A	--	12.5	17	mΩ
Dynamic Electrical Characteristics @ T_j = 25°C (unless otherwise stated)						
C _{iss}	Input Capacitance	V _{DS} =30V, V _{GS} =0V, f=1MHz	970	1140	1310	pF
C _{oss}	Output Capacitance		550	645	740	pF
C _{rss}	Reverse Transfer Capacitance		--	20	30	pF
R _g	Gate Resistance	f=1MHz	--	0.9	--	Ω
Q _g (10V)	Total Gate Charge	V _{DS} =30V, I _D =20A, V _{GS} =10V	--	20	--	nC
Q _g (4.5V)	Total Gate Charge		--	10	--	nC
Q _{gs}	Gate-Source Charge		--	4	--	nC
Q _{gd}	Gate-Drain Charge		--	3.9	--	nC
Switching Characteristics						
t _{d(on)}	Turn-on Delay Time	V _{DD} =30V, I _D =20A, R _G =3Ω, V _{GS} =10V	--	8.4	--	ns
t _r	Turn-on Rise Time		--	34	--	ns
t _{d(off)}	Turn-Off Delay Time		--	19	--	ns
t _f	Turn-Off Fall Time		--	5.6	--	ns
Source- Drain Diode Characteristics @ T_j = 25°C (unless otherwise stated)						
V _{SD}	Forward on voltage	I _{SD} =20A, V _{GS} =0V	--	0.9	1.2	V
t _{rr}	Reverse Recovery Time	T _j =25°C, I _{sd} =20A, V _{GS} =0V	--	26	--	ns
Q _{rr}	Reverse Recovery Charge	di/dt=100A/μs	--	14	--	nC

NOTE:

- ① Repetitive rating; pulse width limited by max junction temperature.
- ② Limited by T_{Jmax}, starting T_J = 25°C, L = 0.5mH, R_G = 25Ω, I_{AS} = 10A, V_{GS} = 10V. Part not recommended for use above this value
- ③ The power dissipation P_{DSM} is based on R_{θJA} and the maximum allowed junction temperature of 150°C.
- ④ Pulse width ≤ 380μs; duty cycle ≤ 2%.

Typical Characteristics

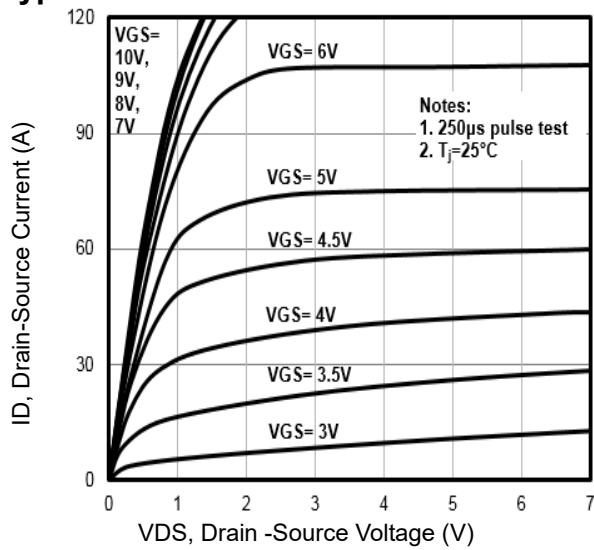


Fig1. Typical Output Characteristics

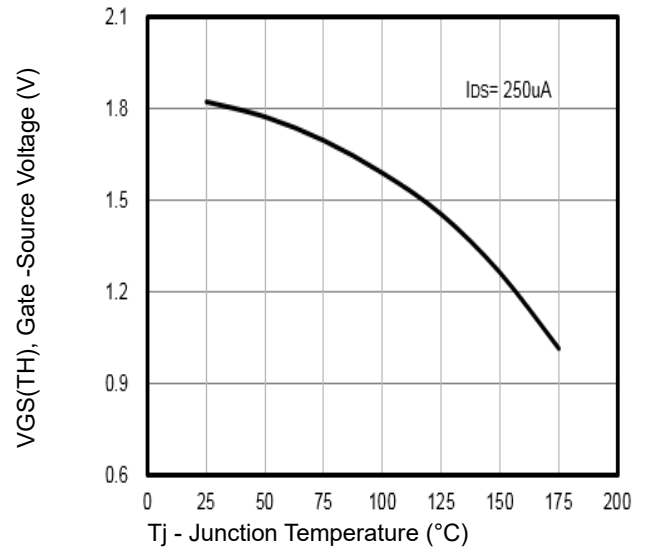


Fig2. $V_{GS(TH)}$ Gate-Source Voltage Vs. T_j

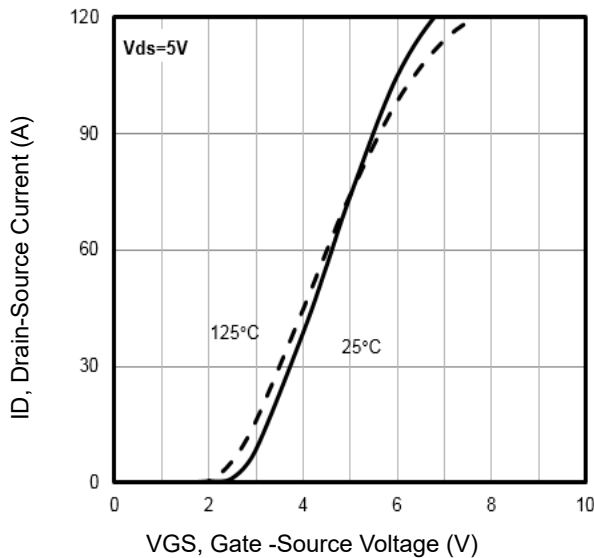


Fig3. Typical Transfer Characteristics

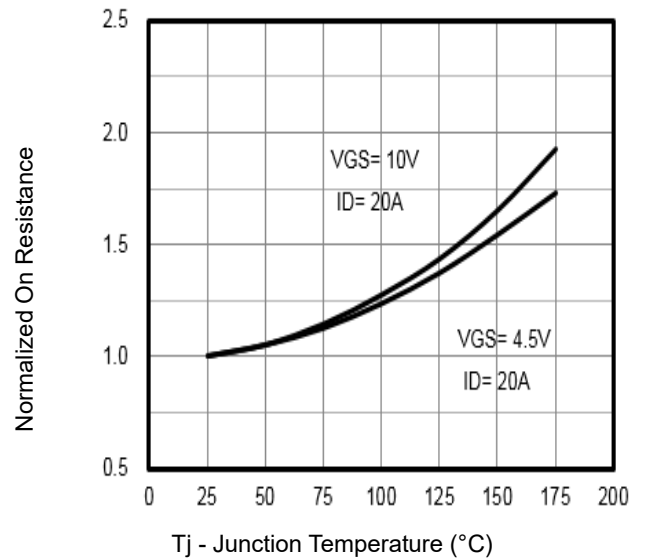


Fig4. Normalized On-Resistance Vs. T_j

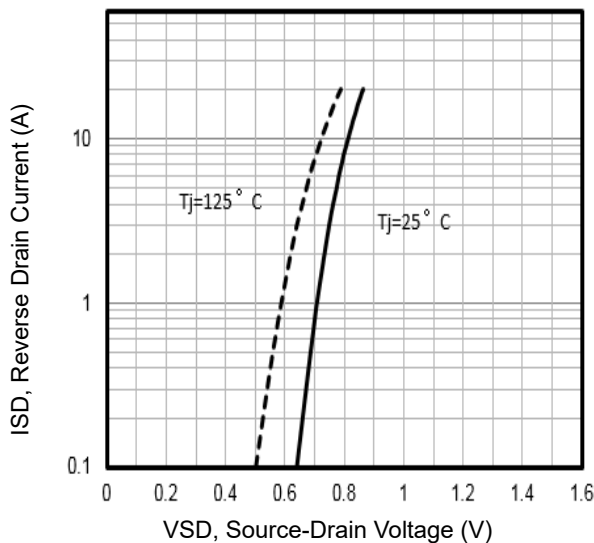


Fig5. Typical Source-Drain Diode Forward Voltage

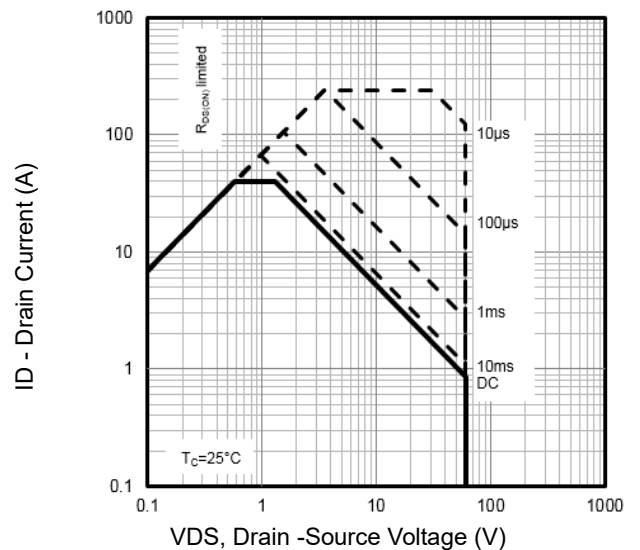


Fig6. Maximum Safe Operating Area

Typical Characteristics

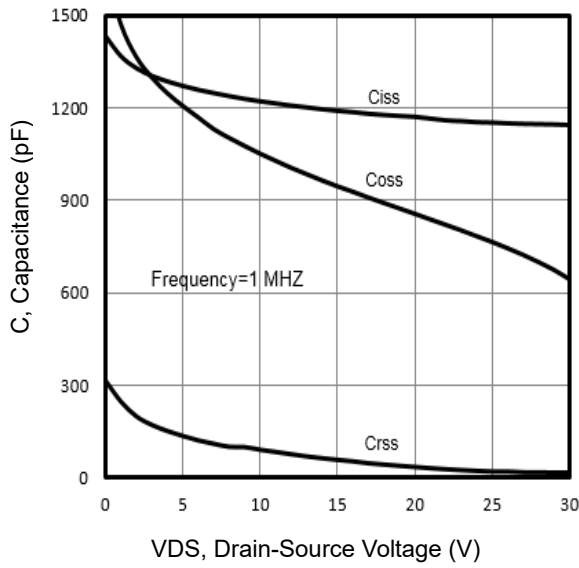


Fig7. Typical Capacitance Vs. Drain-Source Voltage

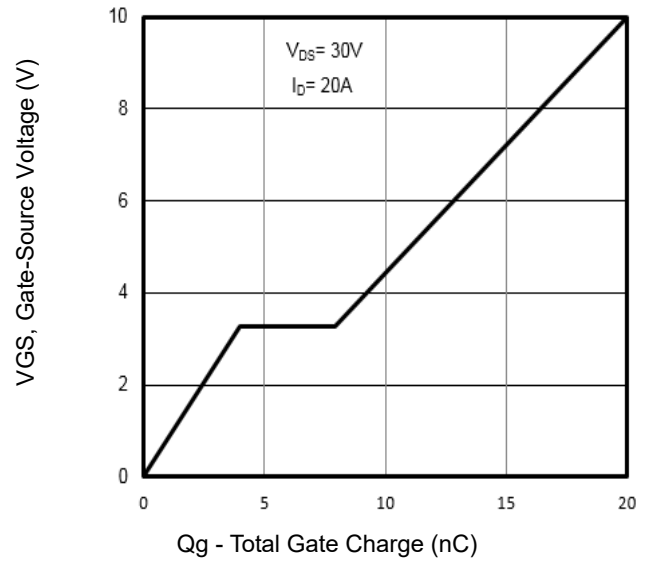


Fig8. Typical Gate Charge Vs. Gate-Source Voltage

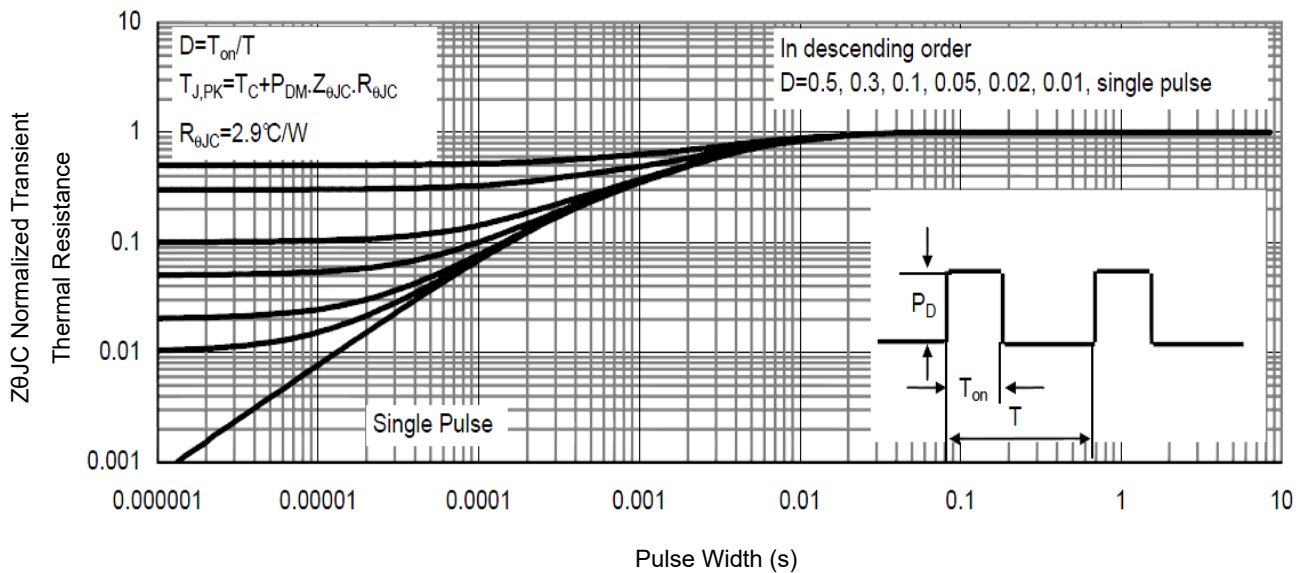


Fig9. Normalized Maximum Transient Thermal Impedance

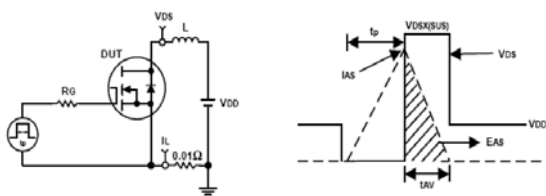


Fig10. Unclamped Inductive Test Circuit and waveforms

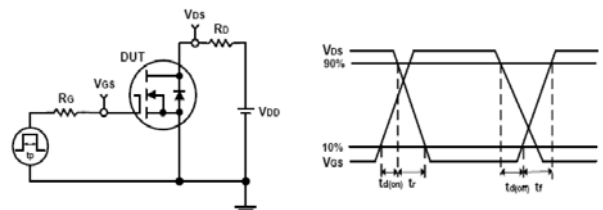
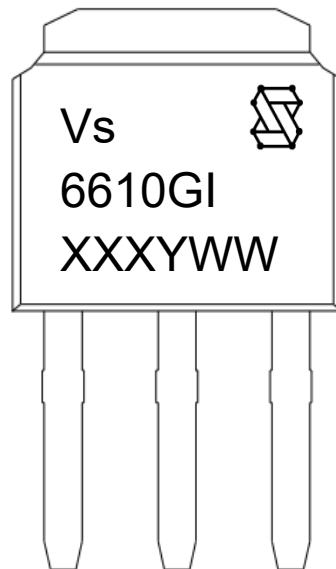
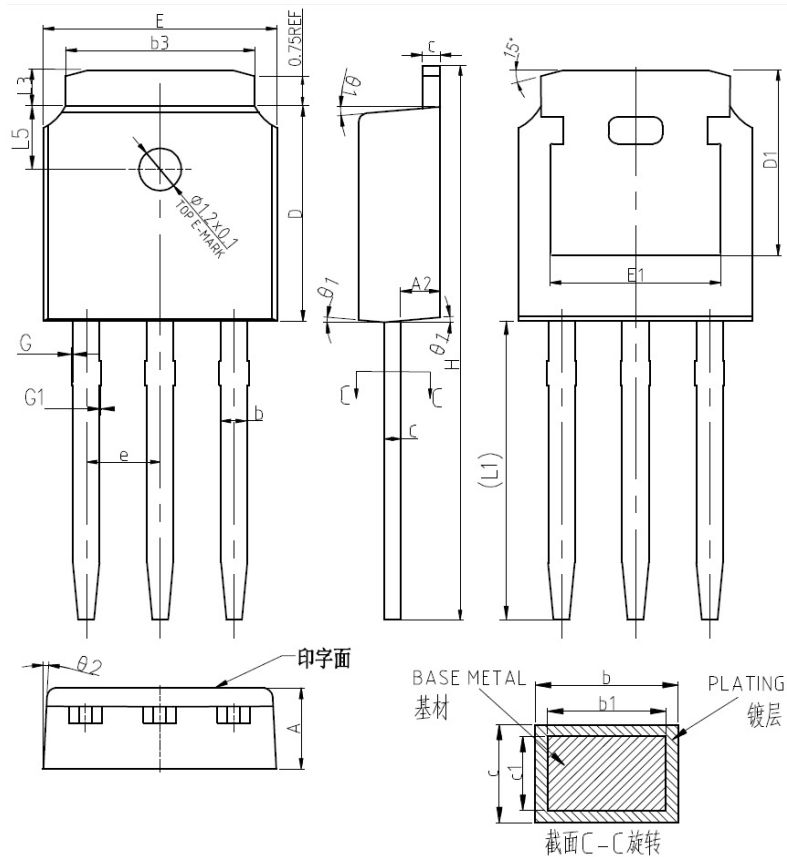


Fig11. Switching Time Test Circuit and waveforms

Marking Information



- 1st line: Vanguard Code (Vs), Vanguard Logo
2nd line: Part Number (6610GI)
3rd line: Date code (XXXYWW)
XXX: Wafer Lot Number Code, code changed with Lot Number
Y: Year Code (e.g. E=2017, F=2018, G=2019, H=2020, etc)
WW: Week Code (01 to 53)

TO-251 Package Outline Data


Symbol	Dimensions (unit: mm)		
	Min	Typ	Max
A	2.20	2.30	2.38
A2	0.97	1.07	1.17
b	0.72	0.78	0.85
b1	0.71	0.76	0.81
b3	5.23	5.33	5.46
c	0.47	0.53	0.58
c1	0.46	0.51	0.56
D	6.00	6.10	6.20
D1	5.30 REF		
E	6.50	6.60	6.70
E1	4.70	4.83	4.92
e	2.286 BSC		
G	0.00	0.04	0.10
G1	0.00	0.04	0.10
H	16.22	16.52	16.82
L1	9.20	9.40	9.60
L3	0.90	1.02	1.25
L5	1.70	1.80	1.90
θ1	5°	7°	9°
θ2	5°	7°	9°

Notes:

1. Refer to JEDEC TO-251 variation AA
2. Dimension "D" and "E" do NOT include mold flash. Mold flash shall not exceed 0.127mm per side.

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